Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/564,416	ANDO ET AL.
Examiner	Art Unit
Sara W. Crane	2811

SEARCHED								
Class	Subclass	Date	Examiner					
257	103	6/06	SWC					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH	STRATEGY	')
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